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 Application/Control No.	Applicant(s)/Patent under Reexamination
10/787,234	YU, IN-KWANG
Examiner	Art Unit

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Wen-Ying P. Chen

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key words search of all databases in EAST	5/3/2006	WPC
Consulted Primary Examiner Andrew Schechter in indicating allowable subject matter.	5/3/2006	WPC ¹
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